



Low-Capacitance, 2/3/4/6-Channel, $\pm 15\text{kV}$ ESD Protection Arrays for High-Speed Data Interfaces

General Description

The MAX3202E/MAX3203E/MAX3204E/MAX3206E are low-capacitance $\pm 15\text{kV}$ ESD-protection diode arrays designed to protect sensitive electronics attached to communication lines. Each channel consists of a pair of diodes that steer ESD current pulses to V_{CC} or GND. The MAX3202E/MAX3203E/MAX3204E/MAX3206E protect against ESD pulses up to $\pm 15\text{kV}$ Human Body Model, $\pm 8\text{kV}$ Contact Discharge, and $\pm 15\text{kV}$ Air-Gap Discharge, as specified in IEC 61000-4-2. These devices have a 5pF capacitance per channel, making them ideal for use on high-speed data I/O interfaces.

The MAX3202E is a two-channel device intended for USB and USB 2.0 applications. The MAX3203E is a triple-ESD structure intended for USB On-the-Go (OTG) and video applications. The MAX3204E is a quad-ESD structure designed for Ethernet and FireWire® applications, and the MAX3206E is a six-channel device designed for cell phone connectors and SVGA video connections.

All devices are available in tiny 4-bump (1.05mm x 1.05mm) WLP, 6-bump (1.05mm x 1.57mm) WLP, 9-bump (1.52mm x 1.52mm) WLP, 6-pin (3mm x 3mm) TDFN, and 12-pin (4mm x 4mm) TQFN packages and are specified for -40°C to $+85^{\circ}\text{C}$ operation.

Applications

USB	Video
USB 2.0	Cell Phones
Ethernet	SVGA Video Connections
FireWire	

Selector Guide

PART	ESD-PROTECTED I/O PORTS
MAX3202EEWS+T	2
MAX3202EETT-T	2
MAX3203EEWT+T	3
MAX3203EETT-T	3
MAX3204EEBT-T	4
MAX3204EETT-T	4
MAX3206EEBL-T	6
MAX3206EETC	6

Pin Configurations appear at end of data sheet.

FireWire is a registered trademark of Apple Computer, Inc.

Features

- ♦ High-Speed Data Line ESD Protection
 - $\pm 15\text{kV}$ —Human Body Model
 - $\pm 8\text{kV}$ —IEC 61000-4-2, Contact Discharge
 - $\pm 15\text{kV}$ —IEC 61000-4-2, Air-Gap Discharge
- ♦ Tiny WLP Package Available
- ♦ Low 5pF Input Capacitance
- ♦ Low 1nA (max) Leakage Current
- ♦ Low 1nA Supply Current
- ♦ +0.9V to +5.5V Supply Voltage Range
- ♦ 2-, 3-, 4-, or 6-Channel Devices Available

Ordering Information

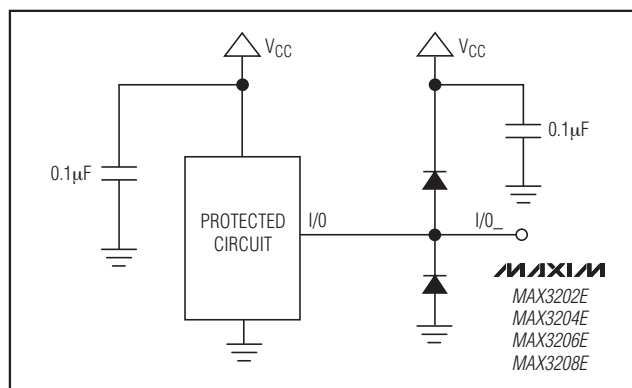
PART	PIN-PACKAGE	TOP MARK
MAX3202EEWS+T	4 WLP	+AA
MAX3202EETT+T	6 TDFN-EP*	+ADQ
MAX3203EEWT+T	6 WLP	+BG
MAX3203EETT+T	6 TDFN-EP*	+ADO
MAX3204EEWT+T	6 WLP	+AL
MAX3204EETT+T	6 TDFN-EP*	+ADP
MAX3206EEWL+T	9 WLP	+AQ
MAX3206EETC+	12 TQFN-EP*	+ACA

*EP = Exposed pad.

Note: All devices operate over -40°C to $+85^{\circ}\text{C}$ temperature range.

+ Denotes a lead(Pb)-free/RoHS-compliant package.

Typical Operating Circuit



Low-Capacitance, 2/3/4/6-Channel, $\pm 15\text{kV}$ ESD Protection Arrays for High-Speed Data Interfaces

ABSOLUTE MAXIMUM RATINGS

V_{CC} to GND -0.3V to +7.0V
 I/O_{-} to GND -0.3V to ($V_{CC} + 0.3\text{V}$)
 Continuous Power Dissipation ($T_A = +70^\circ\text{C}$)
 2×2 WLP (derate 11.5mW/ $^\circ\text{C}$ above $+70^\circ\text{C}$) 920mW
 3×2 WLP (derate 12.3mW/ $^\circ\text{C}$ above $+70^\circ\text{C}$) 984mW
 3×3 WLP (derate 14.1mW/ $^\circ\text{C}$ above $+70^\circ\text{C}$) 1128mW

6-Pin TDFN (derate 24.4mW/ $^\circ\text{C}$ above $+70^\circ\text{C}$) 1951mW
 12-Pin TQFN (derate 16.9mW/ $^\circ\text{C}$ above $+70^\circ\text{C}$) 1349mW
 Operating Temperature Range -40°C to $+85^\circ\text{C}$
 Storage Temperature Range -65°C to $+150^\circ\text{C}$
 Junction Temperature $+150^\circ\text{C}$
 Lead Temperature (soldering, 10s) $+300^\circ\text{C}$
 Soldering Temperature (reflow) $+260^\circ\text{C}$

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

PACKAGE THERMAL CHARACTERISTICS (Note 1)

4 WLP
 Junction-to-Ambient Thermal Resistance (θ_{JA}) 87°C/W
 6 WLP
 Junction-to-Ambient Thermal Resistance (θ_{JA}) 84°C/W
 9 WLP
 Junction-to-Ambient Thermal Resistance (θ_{JA}) 71°C/W

6 TDFN
 Junction-to-Ambient Thermal Resistance (θ_{JA}) 42°C/W
 Junction-to-Case Thermal Resistance (θ_{JC}) 9°C/W
 12 TQFN
 Junction-to-Ambient Thermal Resistance (θ_{JA}) 41°C/W
 Junction-to-Case Thermal Resistance (θ_{JC}) 6°C/W

Note 1: Package thermal resistances were obtained using the method described in JEDEC specification JESD51-7, using a four-layer board. For detailed information on package thermal considerations, refer to www.maxim-ic.com/thermal-tutorial.

ELECTRICAL CHARACTERISTICS

($V_{CC} = +5\text{V} \pm 5\%$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted. Typical values are at $V_{CC} = +5\text{V}$ and $T_A = +25^\circ\text{C}$.) (Note 2)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Supply Voltage	V_{CC}		0.9		5.5	V
Supply Current	I_{CC}			1	100	nA
Diode Forward Voltage	V_F	$I_F = 10\text{mA}$	0.65		0.95	V
Channel Clamp Voltage (Note 3)	V_C	$T_A = +25^\circ\text{C}$, $\pm 15\text{kV}$ Human Body Model, $I_F = 10\text{A}$			$V_{CC} + 25$	V
		Negative transients			-25	
		$T_A = +25^\circ\text{C}$, $\pm 8\text{kV}$ Contact Discharge (IEC 61000-4-2), $I_F = 24\text{A}$			$V_{CC} + 60$	
		Negative transients			-60	
		$T_A = +25^\circ\text{C}$, $\pm 15\text{kV}$ Air-Gap Discharge (IEC 61000-4-2), $I_F = 45\text{A}$			$V_{CC} + 100$	
		Negative transients			-100	
Channel Leakage Current		$T_A = 0^\circ\text{C}$ to $+50^\circ\text{C}$ (Note 4)	-1		+1	nA
Channel Input Capacitance		$V_{CC} = 5\text{V}$, bias of $V_{CC}/2$		5	7	pF
ESD PROTECTION						
Human Body Model				± 15		kV
IEC 61000-4-2 Contact Discharge				± 8		kV
IEC 61000-4-2 Air-Gap Discharge				± 15		kV

Note 2: Limits over temperature are guaranteed by design, not production tested.

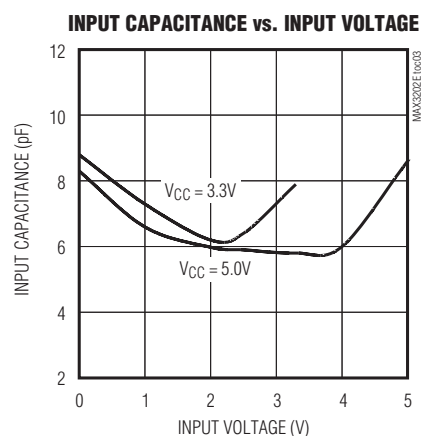
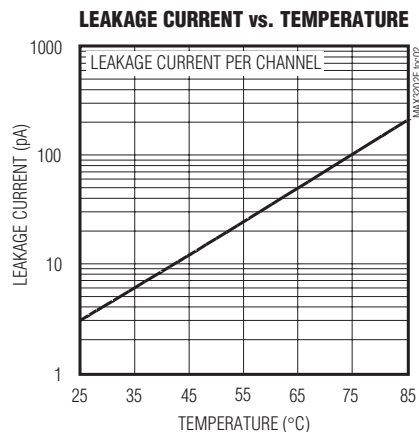
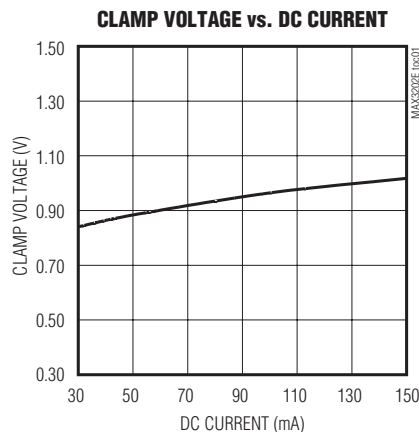
Note 3: Idealized clamp voltages ($L1 = L2 = L3 = 0$) (Figure 1); see the *Applications Information* section for more information.

Note 4: Guaranteed by design. Not production tested.

Low-Capacitance, 2/3/4/6-Channel, ±15kV ESD Protection Arrays for High-Speed Data Interfaces

Typical Operating Characteristics

(VCC = +5V, TA = +25°C, unless otherwise noted.)



Pin/Bump Description

PIN/BUMP								NAME	FUNCTION
MAX3202E		MAX3203E		MAX3204E		MAX3206E			
WLP	TDFN-EP	WLP	TDFN-EP	WLP	TDFN-EP	WLP	TQFN-EP		
A1, B2	3, 6	A1, A2, B3	1, 2, 4	A1, A2, B2, B3	1, 2, 4, 5	A1, A3, B1, B3, C1, C3	1, 2, 3, 7, 8, 9	I/O _−	ESD-Protected Channel
A2	4	B1	3	B1	3	A2	5	GND	Ground
B1	1	A3	6	A3	6	C2	11	VCC	Power-Supply Input. Bypass V _{CC} to GND with a 0.1μF ceramic capacitor.
—	2, 5	—	5	—	—	—	4, 6, 10, 12	N.C.	No Connection. Not internally connected.
—	—	—	—	—	—	—	—	EP	Exposed Pad. Connect to GND. Only for TDFN and TQFN packages.

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Detailed Description

The MAX3202E/MAX3203E/MAX3204E/MAX3206E are diode arrays designed to protect sensitive electronics against damage resulting from ESD conditions or transient voltages. The low input capacitance makes these devices ideal for high-speed data lines. The MAX3202E, MAX3203E, MAX3204E, and MAX3206E protect two, three, four, and six channels, respectively.

The MAX3202E/MAX3203E/MAX3204E/MAX3206E are designed to work in conjunction with a device's intrinsic ESD protection. The MAX3202E/MAX3203E/MAX3204E/MAX3206E limit the excursion of the ESD event to below $\pm 25\text{V}$ peak voltage when subjected to the Human Body Model waveform. When subjected to the IEC 61000-4-2 waveform, the peak voltage is limited to $\pm 60\text{V}$ when subjected to Contact Discharge and $\pm 100\text{V}$ when subjected to Air-Gap Discharge. The device that is being protected by the MAX3202E/MAX3203E/MAX3204E/MAX3206E must be able to withstand these peak voltages plus any additional voltage generated by the parasitic board.

Applications Information

Design Considerations

Maximum protection against ESD damage results from proper board layout (see the *Layout Recommendations* section and Figure 2). A good layout reduces the parasitic series inductance on the ground line, supply line, and protected signal lines.

The MAX3202E/MAX3203E/MAX3204E/MAX3206E ESD diodes clamp the voltage on the protected lines during an ESD event and shunt the current to GND or V_{CC} . In an ideal circuit, the clamping voltage, V_C , is defined as the forward voltage drop, V_F , of the protection diode plus any supply voltage present on the cathode.

For positive ESD pulses:

$$V_C = V_{CC} + V_F$$

For negative ESD pulses:

$$V_C = -V_F$$

In reality, the effect of the parasitic series inductance on the lines must also be considered (Figure 1).

For positive ESD pulses:

$$V_C = V_{CC} + V_{F(D1)} + \left(L1 \times \frac{d(I_{ESD})}{dt} \right) + \left(L2 \times \frac{d(I_{ESD})}{dt} \right)$$

For negative ESD pulses:

$$V_C = - \left(V_{F(D2)} + \left(L1 \times \frac{d(I_{ESD})}{dt} \right) + \left(L3 \times \frac{d(I_{ESD})}{dt} \right) \right)$$

where I_{ESD} is the ESD current pulse.

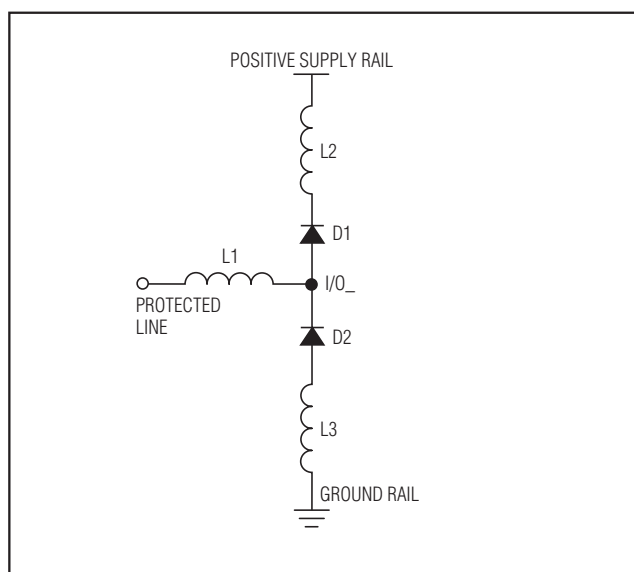


Figure 1. Parasitic Series Inductance

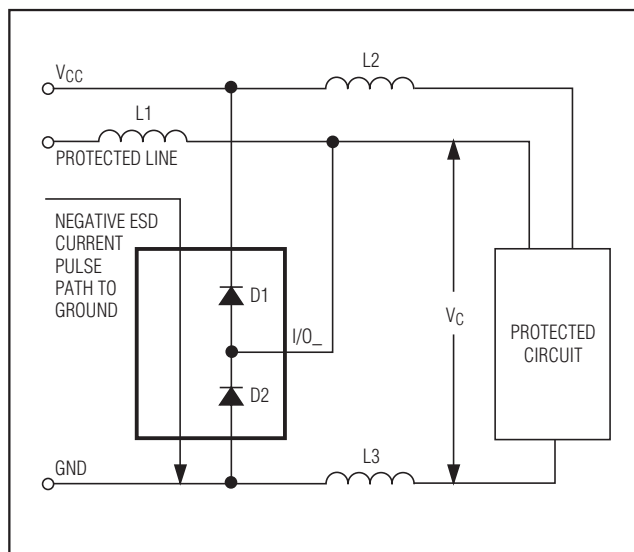


Figure 2. Layout Considerations

MAX3202E/MAX3203E/MAX3204E/MAX3206E

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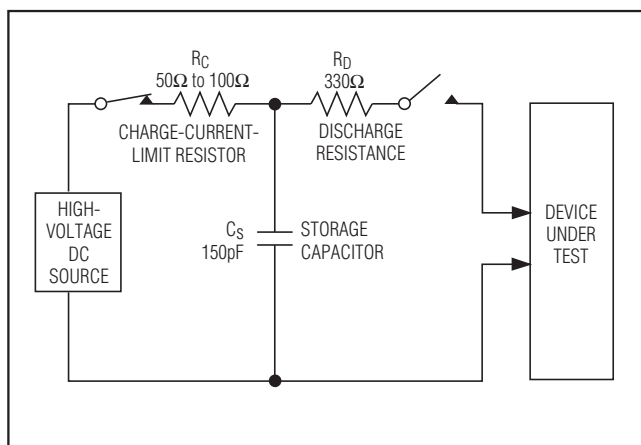


Figure 6. IEC 61000-4-2 ESD Test Model

IEC 61000-4-2

The IEC 61000-4-2 standard covers ESD testing and performance of finished equipment. The MAX3202E/MAX3203E/MAX3204E/MAX3206E help users design equipment that meets Level 4 of IEC 61000-4-2.

The main difference between tests done using the Human Body Model and IEC 61000-4-2 is higher peak current in IEC 61000-4-2. Because series resistance is lower in the IEC 61000-4-2 ESD test model (Figure 6) the ESD-withstand voltage measured to this standard is generally lower than that measured using the Human Body Model. Figure 3 shows the current waveform for the $\pm 8\text{kV}$ IEC 61000-4-2 Level 4 ESD Contact Discharge test.

The Air-Gap Discharge test involves approaching the device with a charged probe. The Contact Discharge method connects the probe to the device before the probe is energized.

Layout Recommendations

Proper circuit-board layout is critical to suppress ESD-induced line transients. The MAX3202E/MAX3203E/MAX3204E/MAX3206E clamp to 100V; however, with improper layout, the voltage spike at the device is much higher. A lead inductance of 10nH with a 45A current spike at a dv/dt of 1ns results in an **ADDITIONAL** 450V spike on the protected line. It is **essential** that the layout of the PC board follows these guidelines:

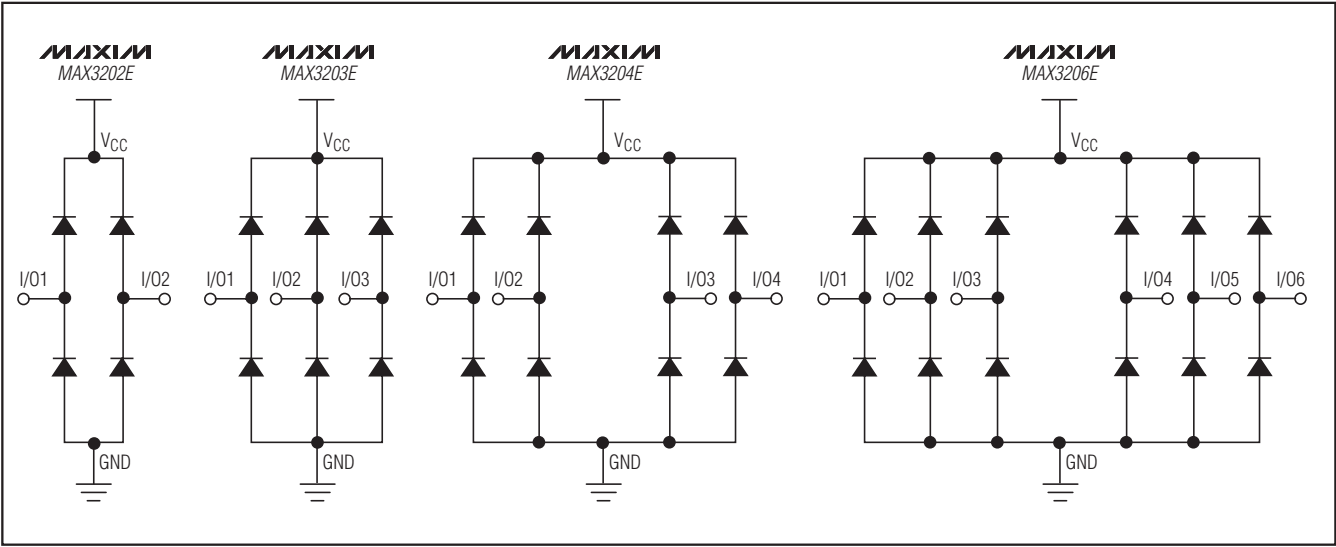
- 1) Minimize trace length between the connector or input terminal, I/O_, and the protected signal line.
- 2) Use separate planes for power and ground to reduce parasitic inductance and to reduce the impedance to the power rails for shunted ESD current.
- 3) Ensure short ESD transient return paths to GND and VCC.
- 4) Minimize conductive power and ground loops.
- 5) Do not place critical signals near the edge of the PC board.
- 6) Bypass VCC to GND with a low-ESR ceramic capacitor as close to VCC as possible.
- 7) Bypass the supply of the protected device to GND with a low-ESR ceramic capacitor as close to the supply pin as possible.

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Table 1. Reliability Test Data

TEST	CONDITIONS	DURATION	FAILURES PER SAMPLE SIZE
Temperature Cycle	-35°C to +85°C, -40°C to +100°C	150 cycles, 900 cycles	0/10, 0/200
Operating Life	$T_A = +70^\circ\text{C}$	240hr	0/10
Moisture Resistance	-20°C to +60°C, 90% RH	240hr	0/10
Low-Temperature Storage	-20°C	240hr	0/10
Low-Temperature Operational	-10°C	24hr	0/10
Solderability	8hr steam age	—	0/15
ESD	$\pm 2000\text{V}$, Human Body Model	—	0/5
High-Temperature Operating Life	$T_J = +150^\circ\text{C}$	168hr	0/45

Functional Diagrams

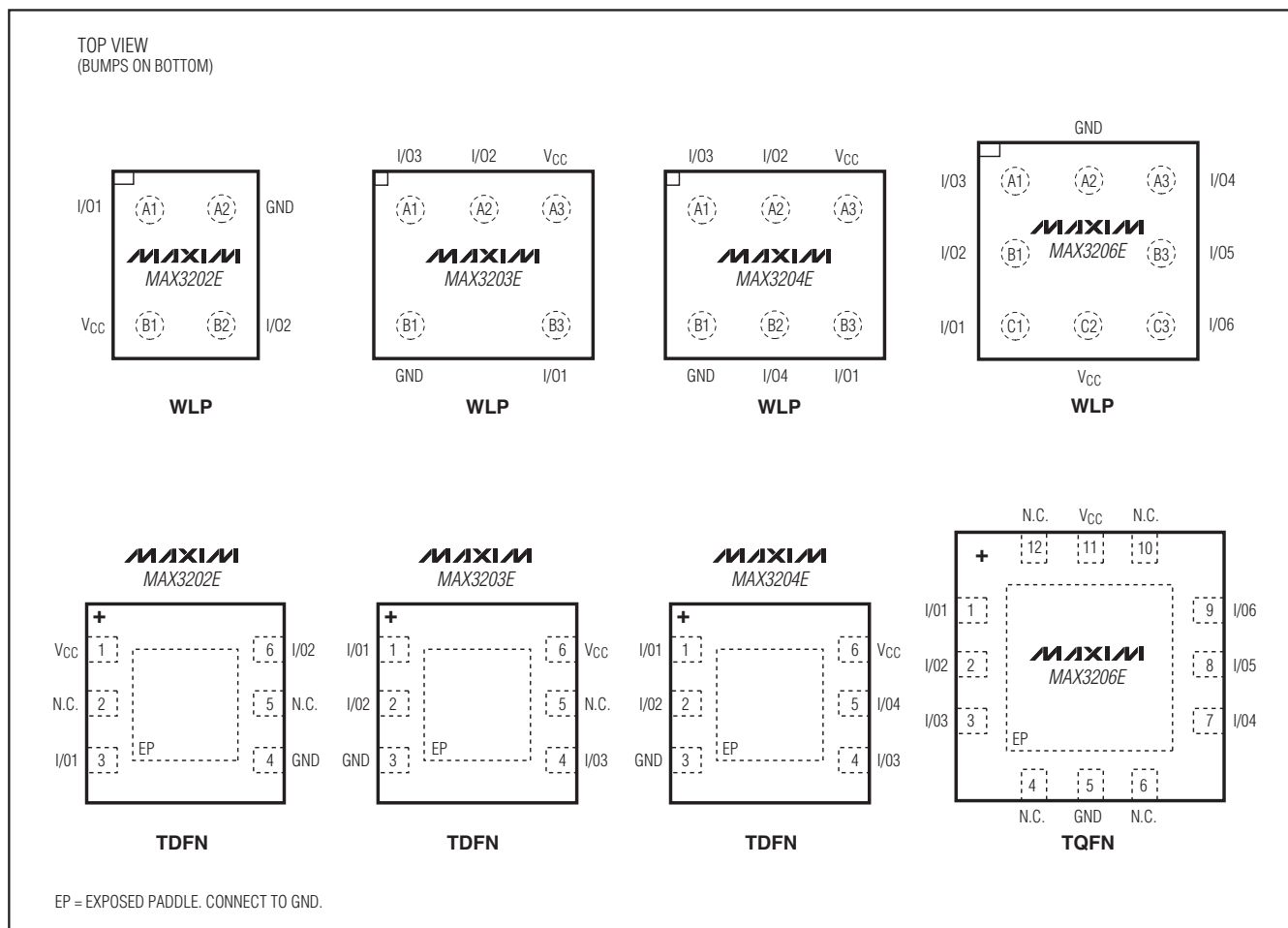


Chip Information

PROCESS: BiCMOS

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Pin Configurations



Package Information

For the latest package outline information and land patterns (footprints), go to www.maxim-ic.com/packages. Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

PACKAGE TYPE	PACKAGE CODE	OUTLINE NO.	LAND PATTERN NO.
4 WLP	W41A1+2	21-0455	Refer to Application Note 1891
6 WLP	W61C1+2	21-0463	Refer to Application Note 1891
9 WLP	W91B1+5	21-0067	Refer to Application Note 1891
6 TDFN-EP	T633+2	21-0137	90-0058
12 TQFN-EP	T1244+4	21-0139	90-0068

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Revision History

MAX3202E/MAX3203E/MAX3204E/MAX3206E

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